FLAT-BASE TYPE INSULATED PACKAGE

#### PM75B4LA060

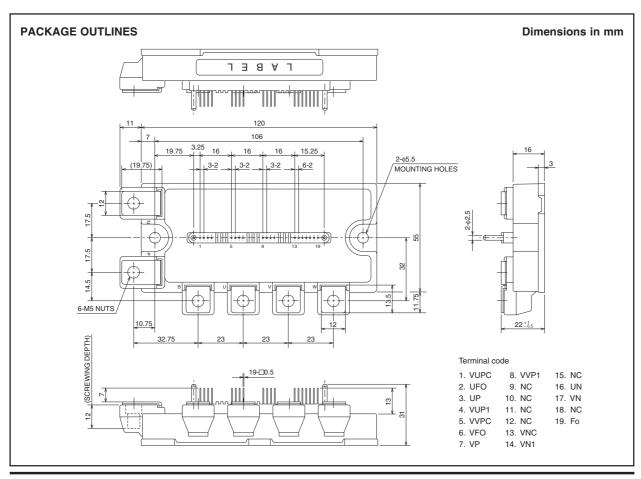


#### FEATURE

- a) Adopting new 5th generation IGBT (CSTBT™) chip, which performance is improved by 1μm fine rule process.
   For example, typical V<sub>ce</sub>(sat)=1.55V @Tj=125°C
- b) Over-temperature protection by detecting Tj of the CSTBT<sup>™</sup> chips and error output is possible from all each conservation upper and lower arm of IPM.
- New small package
   Reduce the package size by 10%, thickness by 22% from S-DASH series.
- 2φ 75A, 600V Current-sense IGBT type inverter
- Monolithic gate drive & protection logic
- Detection, protection & status indication circuits for, shortcircuit, over-temperature & under-voltage (P-Fo available from upper arm devices)
- UL Recognized Yellow Card No.E80276(N)
   File No.E80271

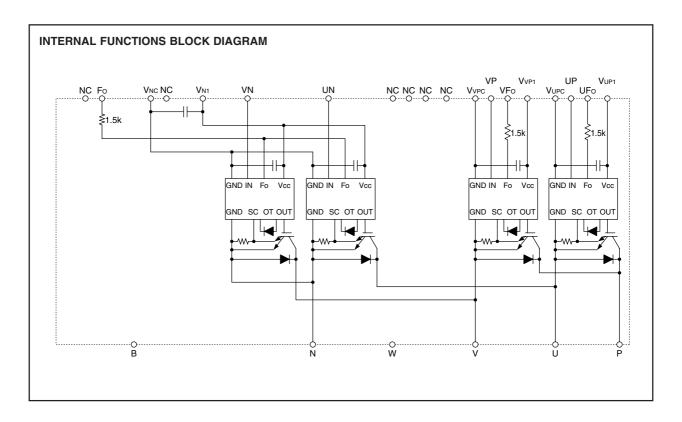
### **APPLICATION**

Photo voltaic power conditioner





FLAT-BASE TYPE INSULATED PACKAGE



## **MAXIMUM RATINGS** (Tj = $25^{\circ}$ C, unless otherwise noted)

## **INVERTER PART**

Symbol	Parameter	Condition	Ratings	Unit
VCES	Collector-Emitter Voltage	VD = 15V, VCIN = 15V	600	V
±IC	Collector Current	Tc = 25°C	75	Α
±ICP	Collector Current (Peak)	Tc = 25°C	150	Α
Pc	Collector Dissipation	Tc = 25°C	390	W
Tj	Junction Temperature		<b>−20</b> ~ +150	°C

## **CONTROL PART**

Symbol	Parameter	Condition	Ratings	Unit
VD Supply Voltage		Applied between: Vup1-Vupc	20	V
		VVP1-VVPC, VN1-VNC		
VCIN	Input Voltage	Applied between : UP-VUPC, VP-VVPC UN • VN-VNC	20	V
VFO	Fault Output Supply Voltage	Applied between: UFO-VUPC, VFO-VVPC, FO-VNC	20	V
IFO	Fault Output Current	Sink current at UFO, VFO, FO terminals	20	mA

FLAT-BASE TYPE INSULATED PACKAGE

### **TOTAL SYSTEM**

Symbol	Parameter	Condition	Ratings	Unit
VCC(PROT)	Supply Voltage Protected by SC	$VD = 13.5 \sim 16.5V$ , Inverter Part, $T_j = +125^{\circ}C$ Start	450	V
VCC(surge)	Supply Voltage (Surge)	Applied between : P-N, Surge value	500	V
Tstg	Storage Temperature		<b>−</b> 40 ~ +125	°C
Viso	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base, AC 1 min.	2500	Vrms

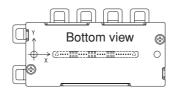
### THERMAL RESISTANCES

		Condition					
Symbol	Parameter			Min.	Тур.	Max.	Unit
Rth(j-c)Q	Junction to case Thermal	Inverter IGBT part (per 1/4 module)	(Note-1)	_	_	0.32	
Rth(j-c)F	Resistances	Inverter FWDi part (per 1/4 module)	(Note-1)	_	_	0.53	°C/W
Rth(c-f)	Contact Thermal Resistance	Case to fin, (per 1 module)			0.000	C/ <b>VV</b>	
		Thermal grease applied	(Note-1)	_	_	0.038	

(Note-1) Tc (under the chip) measurement point is below.

(unit: mm)

arm	UP		V	Р	U	N	V	N
axis	IGBT	FWDi	IGBT	FWDi	IGBT	FWDi	IGBT	FWDi
Х	30.4	30.4	61.7	61.7	39.7	39.7	52.4	52.4
Υ	-8.3	-0.8	-8.3	-0.8	6.3	-1.2	6.3	-1.2



## **ELECTRICAL CHARACTERISTICS** (Tj = 25°C, unless otherwise noted)

### **INVERTER PART**

0	D	Condition			Unit		
Symbol	Parameter			Min.	Тур.	Max.	Offic
V05(4)	Collector-Emitter	VD = 15V, IC = 75A	Tj = 25°C	_	1.7	2.3	V
VCE(sat)	Saturation Voltage	VCIN = 0V (Fig. 1)	Tj = 125°C	_	1.55	2.0	V
VEC	FWDi Forward Voltage	-IC = 75A, VD = 15V, VCIN = 15V	(Fig. 2)	_	2.2	3.3	V
ton		Vo. 15V Vois OV : 15V		0.3	0.7	1.4	
trr		VD = 15V, VCIN = 0V↔15V		_	0.1	0.2	
tc(on)	Switching Time	VCC = 300V, IC = 75A		_	0.2	0.4	μS
toff		Tj = 125°C	(Fig. 0.4)	_	0.9	1.8	
tc(off)		Inductive Load	(Fig. 3,4)	_	0.2	0.4	
loso	Collector-Emitter	Vos Vosa Volu 15V (Fig. 5)	Tj = 25°C	_	_	1	A
ICES	Cutoff Current	VCE = VCES, VCIN = 15V (Fig. 5)	Tj = 125°C	_	_	10	mA

FLAT-BASE TYPE INSULATED PACKAGE

## **CONTROL PART**

Cumbal	Parameter Condition		Limits			11-2	
Symbol	Parameter	Condition		Min.	Тур.	Max.	Unit
ID	Circuit Current	VD = 15V, VCIN = 15V	VN1-VNC	_	15	25	mA
וט	Circuit Current	VD = 13V, VCIN = 13V	V*P1-V*PC	_	6	12	IIIA
Vth(ON)	Input ON Threshold Voltage	Applied between : UP-VUPC, VP-VVPC		1.2	1.5	1.8	V
Vth(OFF)	Input OFF Threshold Voltage	Un • Vn-Vnc		1.7	2.0	2.3	V
SC	Short Circuit Trip Level	-20 ≤ Tj ≤ 125°C, VD = 15V	(Fig. 3,6)	150	_	_	Α
toff(SC)	Short Circuit Current Delay Time	VD = 15V	(Fig. 3,6)	_	0.2	_	μS
OT	O T	VD = 15V	Trip level	135	145	_	°C
OTr	Over Temperature Protection	Detect Tj of IGBT chip	Reset level	_	125	_	
UV	Supply Circuit Under-Voltage	–20 ≤ T <sub>i</sub> ≤ 125°C	Trip level	11.5	12.0	12.5	V
UVr	Protection	-20 S 1) S 125 O	Reset level	_	12.5	_	·
IFO(H)	Fault Output Current	VD = 15V, VFO = 15V	(Note-2)	_	_	0.01	mA
IFO(L)	Fault Output Current	VD = 13V, VFO = 13V	(14016-2)	_	10	15	IIIA
tFO	Minimum Fault Output Pulse Width	VD = 15V	(Note-2)	1.0	1.8	_	ms

(Note-2) Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

#### **MECHANICAL RATINGS AND CHARACTERISTICS**

Down was to w		Condition		Limits			Unit
Symbol	Parameter	Condition		Min.	Тур.	Max.	Unit
_	Mounting torque	Main terminal	screw : M5	2.5	3.0	3.5	N•m
_	Mounting torque	Mounting part	screw : M5	2.5	3.0	3.5	N•m
_	Weight	_		_	380	_	g

## RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Condition		Recommended value	Unit
Vcc	Supply Voltage	Applied across P-N terminals		≤ 450	V
VD	Control Supply Voltage	Applied between: VuP1-VuPC, VvP1-VvPC VN1-VNC	(Note-3)	15 ± 1.5	V
VCIN(ON)	Input ON Voltage	Applied between : UP-VUPC, VP-VVPC		≤ 0.8	v
VCIN(OFF)	Input OFF Voltage	Un • Vn-Vnc		≥ 9.0	V
fPWM	PWM Input Frequency	Using Application Circuit of Fig. 8		≤ 20	kHz
tdead	Arm Shoot-through Blocking Time	For IPM's each input signals	(Fig. 7)	≥ 2.0	μS

(Note-3) With ripple satisfying the following conditions : dv/dt swing  $\leq \pm 5V/\mu s$ , Variation  $\leq 2V$  peak to peak

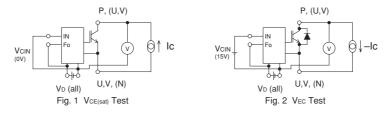


FLAT-BASE TYPE INSULATED PACKAGE

#### PRECAUTIONS FOR TESTING

- Before appling any control supply voltage (VD), the input terminals should be pulled up by resistores, etc. to their corresponding supply voltage and each input signal should be kept off state.
   After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above VCES rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)



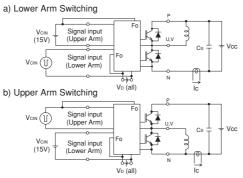
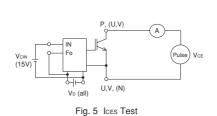


Fig. 3 Switching Time and SC Test Circuit

Fig. 4 Switching Time Test Waveform



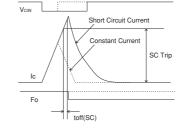
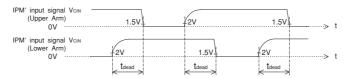


Fig. 6 SC Test Waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value

Fig. 7 Dead Time Measurement Point Example



FLAT-BASE TYPE INSULATED PACKAGE

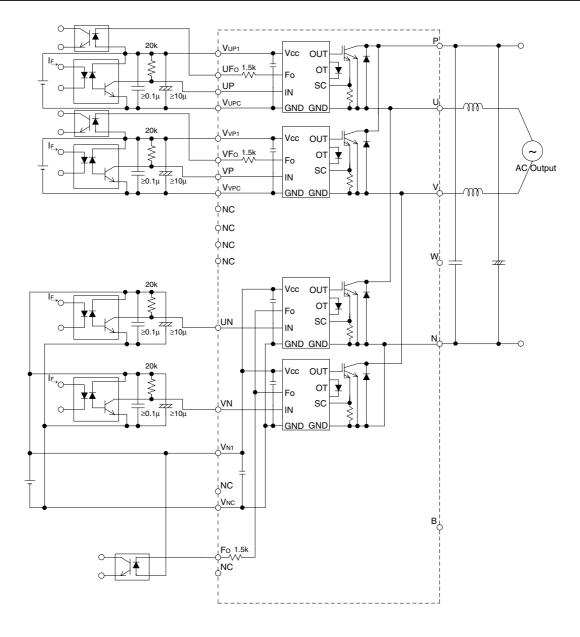


Fig. 8 Application Example Circuit

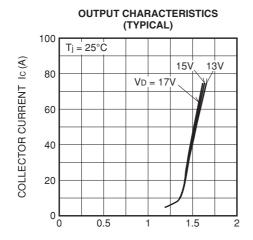
#### NOTES FOR STABLE AND SAFE OPERATION;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: tPLH, tPHL  $\leq 0.8 \mu s$ , Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 3 isolated control power supplies (VD). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.



FLAT-BASE TYPE INSULATED PACKAGE

#### **PERFORMANCE CURVES**

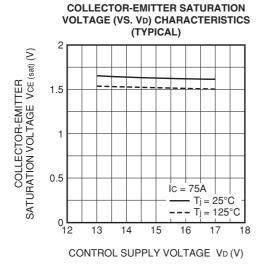


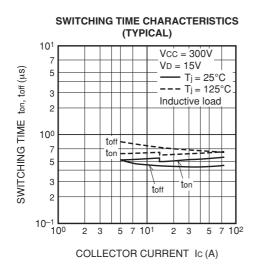
COLLECTOR-EMITTER SATURATION VOLTAGE VCE (sat) (V)

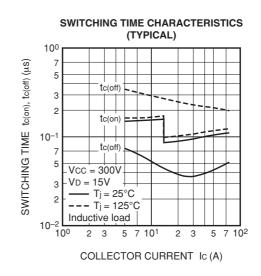
# VOLTAGE (VS. Ic) CHARACTERISTICS (TYPICAL) 2 VD = 15V 1.5 VD = 15V 1.

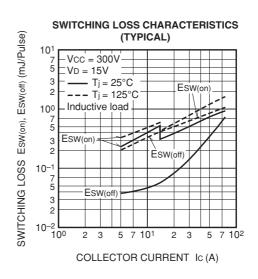
**COLLECTOR-EMITTER SATURATION** 

COLLECTOR CURRENT Ic (A)



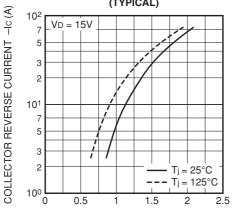






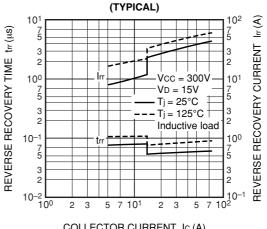
**FLAT-BASE TYPE INSULATED PACKAGE** 

#### **FWDi FORWARD VOLTAGE CHARACTERISTICS** (TYPICAL)



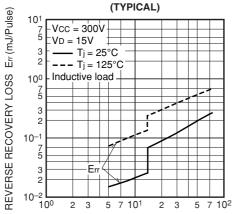
EMITTER-COLLECTOR VOLTAGE VEC (V)

## **FWDi REVERSE RECOVERY CHARACTERISTICS**



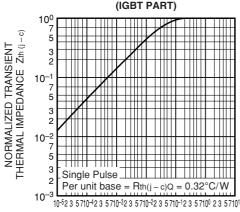
COLLECTOR CURRENT Ic (A)

## FWDi REVERSE RECOVERY LOSS CHARACTERISTICS



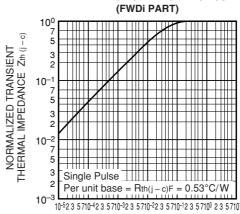
COLLECTOR REVERSE CURRENT -Ic (A)

#### TRANSIENT THERMAL **IMPEDANCE CHARACTERISTICS** (IGBT PART)



TIME (s)

TRANSIENT THERMAL **IMPEDANCE CHARACTERISTICS** 



TIME (s)

# **Important Notice**

The information contained in this datasheet shall in no event be regarded as a guarantee of conditions or characteristics. This product has to be used within its specified maximum ratings, and is subject to customer's compliance with any applicable legal requirement, norms and standards.

Except as otherwise explicitly approved by Mitsubishi Electric Corporation in a written document signed by authorized representatives of Mitsubishi Electric Corporation, our products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

In usage of power semiconductor, there is always the possibility that trouble may occur with them by the reliability lifetime such as Power Cycle, Thermal Cycle or others, or when used under special circumstances (e.g. condensation, high humidity, dusty, salty, highlands, environment with lots of organic matter / corrosive gas / explosive gas, or situations which terminals of semiconductor products receive strong mechanical stress). Therefore, please pay sufficient attention to such circumstances. Further, depending on the technical requirements, our semiconductor products may contain environmental regulation substances, etc. If there is necessity of detailed confirmation, please contact our nearest sales branch or distributor.

The contents or data contained in this datasheet are exclusively intended for technically trained staff. Customer's technical departments should take responsibility to evaluate the suitability of Mitsubishi Electric Corporation product for the intended application and the completeness of the product data with respect to such application. In the customer's research and development, please evaluate it not only with a single semiconductor product but also in the entire system, and judge whether it's applicable. As required, pay close attention to the safety design by installing appropriate fuse or circuit breaker between a power supply and semiconductor products to prevent secondary damage. Please also pay attention to the application note and the related technical information.

# Keep safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

# Notes regarding these materials

- •These materials are intended as a reference to assist our customers in the selection of the Mitsubishi Electric Semiconductor product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Mitsubishi Electric Corporation or a third party.
- •Mitsubishi Electric Corporation assumes no responsibility for any damage, or infringement of any thirdparty's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.
- •All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Mitsubishi Electric Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for the latest product information before purchasing a product listed herein.

The information described here may contain technical inaccuracies or typographical errors. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.

Please also pay attention to information published by Mitsubishi Electric Corporation by various means, including the Mitsubishi Electric Semiconductor home page (http://www.MitsubishiElectric.com/semiconductors/).

- •When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.
- •Mitsubishi Electric Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.
- •The prior written approval of Mitsubishi Electric Corporation is necessary to reprint or reproduce in whole or in part these materials.
- •If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.
- Any diversion or re-export contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.
- •Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for further details on these materials or the products contained therein.

Generally the listed company name and the brand name are the trademarks or registered trademarks of the respective companies.